## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10789217	KIM ET AL.	
Examiner	Art Unit	
Nauven, Leon-Viet Q	2611	

SEARCHED						
Class	Subclass	Date	Examiner			
375	350, 355, 376	4/3/07	LVN			

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor name search for double patenting in PALM	4/2/07	LVN		
EAST search history	4/2/07- 4/3/07,7/25/07- 7/26/07	LVN		
Consulted with SPE David Payne about allowability of dependent claims	4/3/07	LVN		
Consulted with Primary Khai Tran about primary reference	4/3/07	LVN		
Consulted with SPE David Payne about finality of the application	7/25/07	LVN		

INTERFERENCE SEARCH							
Class	Subclass	Date	Examiner				
375	350, 355, 376	11/19/07	LVN				

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